

Edition 1.0 2017-08

INTERNATIONAL STANDARD

AMENDMENT 2

Semiconductor devices — STANDARD PREVIEW Part 16-4: Microwave integrated circuits — Switches (Standards.iten.ai)

IEC 60747-16-4:2004/AMD2:2017 https://standards.iteh.ai/catalog/standards/sist/47c2608e-4d9a-4d32-b676-a2e200f865a9/iec-60747-16-4-2004-amd2-2017





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<u>IEC 60747-16-4:2004/AMD2:2017</u> https://standards.iteh.ai/catalog/standards/sist/47c2608e-4d9a-4d32-b676-a2e200f865a9/iec-60747-16-4-2004-amd2-2017

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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FOREWORD

This amendment has been prepared by subcommittee 47E: Discrete semiconductor devices, of IEC technical committee 47: Semiconductor devices.

The text of this amendment is based on the following documents:

CDV	Report on voting
47E/546/CDV	47E/563/RVC

Full information on the voting for the approval of this amendment can be found in the report on voting indicated in the above table.

The committee has decided that the contents of this amendment and the base publication will remain unchanged until the stability date indicated on the IEC website under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

reconfirmed.

amended.

- withdrawn,
- replaced by a revised edition, or
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A bilingual version of this publication may be issued at a later date.

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CONTENTS

Replace the existing titles of subclauses 5.7 and 5.8 with the following new titles:

- 5.7 Adjacent channel power ratio $(P_{adi}/P_{o(mod)})$
- 5.8 *n*th order harmonic distortion ratio (P_{nth}/P_1)

2 Normative references

Replace the existing references IEC 60617, IEC 60747-1 and IEC 60747-16-1, including the amendments brought to them by Amendment 1 as follows:

IEC 60617, Graphical symbols for diagrams (available from http://std.iec.ch/iec60617)

IEC 60747-1:2006, Semiconductor devices – Part 1: General

IEC 60747-1:2006/AMD1:2010

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IEC 60747-16-1:2001, Semiconductor devices – Part 16-1: Microwave integrated circuits – Amplifiers

IEC 60747-16-1:2001/AMD1:2007 IEC 60747-16-1:2001/AMD2:2017

3 Terms and definitions

Replace the existing terminological entry 3.10 as follows:

3.10

adjacent channel power ratio

 $P_{\rm adi}/P_{\rm o(mod)}$

ratio of the total output power in a specified frequency band away from a specified carrier signal frequency to the total power in a specified carrier signal frequency band, when a modulation signal is supplied

[SOURCE: IEC 60747-16-1:2001/AMD2:2017, 3.21]

Replace the existing terminological entry 3.11 and the amendments brought to it by Amendment 1 as follows:

3.11

nth order harmonic distortion ratio P_{nth}/P_1 ITEH STANDARD PREVIEW

ratio of the power of the nth order harmonic component measured at the output port of the device to the power of the fundamental frequency measured at the output port

[SOURCE: IEC 60747-16-1:2001/AMD2:201743014]AMD2:2017

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4.6 Electrical characteristics 200f865a9/iec-60747-16-4-2004-amd2-2017

Replace the existing parameters 4.6.12 and 4.6.13 and the amendments brought to them by Amendment 1 with the following new parameters:

Subclause	Parameters	Min.	Typical ^a	Max.
4.6.12	Adjacent channel power ratio (where appropriate)		+	+
4.6.13	nth order harmonic distortion ratio (where appropriate)		+	+

5.7 Adjacent channel power ratio $(P_{o(mod)}/P_{adj})$

Replace the existing title of this subclause with the following new title:

5.7 Adjacent channel power ratio $(P_{adi}/P_{o(mod)})$

5.7.3 Principle of measurements

Replace the existing second sentence in the first paragraph with the following new sentence:

Adjacent channel power ratio $P_{adj}/P_{o(mod)}$ is the ratio of P_{adj} to $P_{o(mod)}$.

Replace the existing second paragraph and Equation (14) with the following:

 $P_{\rm adi}/P_{\rm o(mod)}$ in dBc is given as the following equation in the circuit of Figure 6.

$$P_{\text{adj}}/P_{\text{o(mod)}} = P_{\text{adj}} - P_{\text{o(mod)}} = P_3 - P_2$$
 (14)

Replace the existing last sentence of this subclause with the following new sentence:

 $P_{\text{adj}}/P_{\text{o(mod)}}$ is expressed in dBc.

5.7.6 Measurement procedure

Replace the existing last sentence with the following new sentence:

Adjacent channel power ratio $P_{\text{adj}}/P_{\text{o(mod)}}$ is calculated from Equation (14).

5.8 *n*th order harmonic distortion ratio (P_1/P_{nth})

Replace the existing title of subclause 5.8 and the amendments brought to it by Amendment 1 with the following new title:

5.8 *n*th order harmonic distortion ratio (P_{nth}/P_1)

5.8.3 Principle of measurements

Replace the existing first paragraph and the amendments brought to it by Amendment 1 with the following new paragraph:

The *n*th order harmonic distortion ratio P_{nth}/P_{1} in dBc is derived from the following equations:

Replace the existing Equation (17) and the amendments brought to it by Amendment 1 with the following new equation: (standards.iteh.ai)

$$\underline{\text{IEP}_{\textbf{nth}}/41-\overline{7}6P_{\textbf{b}(\textbf{nth})/AN}}\underline{\text{locately}}7$$
https://standards.iteh.ai/catalog/standards/sist/47c2608e-4d9a-4d32-b676-

Replace the existing last sentence and the amendments brought to it by Amendment 1 with the following new sentence:

 $P_{o(1st)}$, $P_{o(nth)}$, $P_{E(1st)}$ and $P_{E(nth)}$ are expressed in dBm. $L_{(1st)}$ and $L_{(nth)}$ are expressed in dB.

5.8.5 Measurement procedure

Replace the existing last sentence and the amendments brought to it by Amendment 1 with the following new sentence:

The *n*th order harmonic distortion ratio P_{nth}/P_1 is calculated from Equations (15), (16) and (17).

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